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### Applications of "[Embedded - Microcontrollers](#)"

#### Details

Product Status	Active
Core Processor	HCS12
Core Size	16-Bit
Speed	25MHz
Connectivity	CANbus, I <sup>2</sup> C, SCI, SPI
Peripherals	PWM, WDT
Number of I/O	91
Program Memory Size	256KB (256K x 8)
Program Memory Type	FLASH
EEPROM Size	4K x 8
RAM Size	12K x 8
Voltage - Supply (Vcc/Vdd)	2.35V ~ 5.25V
Data Converters	A/D 16x10b
Oscillator Type	Internal
Operating Temperature	-40°C ~ 85°C (TA)
Mounting Type	Surface Mount
Package / Case	112-LQFP
Supplier Device Package	112-LQFP (20x20)
Purchase URL	<a href="https://www.e-xfl.com/product-detail/nxp-semiconductors/mc9s12dg256cpve">https://www.e-xfl.com/product-detail/nxp-semiconductors/mc9s12dg256cpve</a>

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# Section 1 IntroductionMC9S12DT256

## 1.1 Overview

The MC9S12DT256 microcontroller unit (MCU) is a 16-bit device composed of standard on-chip peripherals including a 16-bit central processing unit (HCS12 CPU), 256K bytes of Flash EEPROM, 12K bytes of RAM, 4K bytes of EEPROM, two asynchronous serial communications interfaces (SCI), three serial peripheral interfaces (SPI), an 8-channel IC/OC enhanced capture timer, two 8-channel, 10-bit analog-to-digital converters (ADC), an 8-channel pulse-width modulator (PWM), a digital Byte Data Link Controller (BDLC), 29 discrete digital I/O channels (Port A, Port B, Port K and Port E), 20 discrete digital I/O lines with interrupt and wakeup capability, three CAN 2.0 A, B software compatible modules (MSCAN12), and an Inter-IC Bus. The MC9S12DT256 has full 16-bit data paths throughout. However, the external bus can operate in an 8-bit narrow mode so single 8-bit wide memory can be interfaced for lower cost systems. The inclusion of a PLL circuit allows power consumption and performance to be adjusted to suit operational requirements.

## 1.2 Features

- HCS12 Core
  - 16-bit HCS12 CPU
    - i. Upward compatible with M68HC11 instruction set
    - ii. Interrupt stacking and programmer's model identical to M68HC11
    - iii. Instruction queue
    - iv. Enhanced indexed addressing
  - MEBI (Multiplexed External Bus Interface)
  - MMC (Module Mapping Control)
  - INT (Interrupt control)
  - BKP (Breakpoints)
  - BDM (Background Debug Mode)
- CRG
  - Low current Colpitts or Pierce oscillator
  - PLL
  - COP watchdog
  - Real time interrupt
  - Clock Monitor
- 8-bit and 4-bit ports with interrupt functionality
  - Digital filtering

**\$0040 - \$007F**

**ECT (Enhanced Capture Timer 16 Bit 8 Channels)**

Address	Name		Bit 7	Bit 6	Bit 5	Bit 4	Bit 3	Bit 2	Bit 1	Bit 0
\$0053	TC1 (lo)	Read: Write:	Bit 7	6	5	4	3	2	1	Bit 0
\$0054	TC2 (hi)	Read: Write:	Bit 15	14	13	12	11	10	9	Bit 8
\$0055	TC2 (lo)	Read: Write:	Bit 7	6	5	4	3	2	1	Bit 0
\$0056	TC3 (hi)	Read: Write:	Bit 15	14	13	12	11	10	9	Bit 8
\$0057	TC3 (lo)	Read: Write:	Bit 7	6	5	4	3	2	1	Bit 0
\$0058	TC4 (hi)	Read: Write:	Bit 15	14	13	12	11	10	9	Bit 8
\$0059	TC4 (lo)	Read: Write:	Bit 7	6	5	4	3	2	1	Bit 0
\$005A	TC5 (hi)	Read: Write:	Bit 15	14	13	12	11	10	9	Bit 8
\$005B	TC5 (lo)	Read: Write:	Bit 7	6	5	4	3	2	1	Bit 0
\$005C	TC6 (hi)	Read: Write:	Bit 15	14	13	12	11	10	9	Bit 8
\$005D	TC6 (lo)	Read: Write:	Bit 7	6	5	4	3	2	1	Bit 0
\$005E	TC7 (hi)	Read: Write:	Bit 15	14	13	12	11	10	9	Bit 8
\$005F	TC7 (lo)	Read: Write:	Bit 7	6	5	4	3	2	1	Bit 0
\$0060	PACTL	Read: Write:	0	PAEN	PAMOD	PEDGE	CLK1	CLK0	PAOVI	PAI
\$0061	PAFLG	Read: Write:	0	0	0	0	0	0	PAOVF	PAIF
\$0062	PACN3 (hi)	Read: Write:	Bit 7	6	5	4	3	2	1	Bit 0
\$0063	PACN2 (lo)	Read: Write:	Bit 7	6	5	4	3	2	1	Bit 0
\$0064	PACN1 (hi)	Read: Write:	Bit 7	6	5	4	3	2	1	Bit 0
\$0065	PACN0 (lo)	Read: Write:	Bit 7	6	5	4	3	2	1	Bit 0
\$0066	MCCTL	Read: Write:	MCZI	MODMC	RDMCL	0 ICLAT	0 FLMC	MCEN	MCPR1	MCPR0
\$0067	MCFLG	Read: Write:	MCZF	0	0	0	POLF3	POLF2	POLF1	POLF0
\$0068	ICPAR	Read: Write:	0	0	0	0	PA3EN	PA2EN	PA1EN	PA0EN
\$0069	DLYCT	Read: Write:	0	0	0	0	0	0	DLY1	DLY0
\$006A	ICOVW	Read: Write:	NOVW7	NOVW6	NOVW5	NOVW4	NOVW3	NOVW2	NOVW1	NOVW0
\$006B	ICSYS	Read: Write:	SH37	SH26	SH15	SH04	TFMOD	PACMX	BUFEN	LATQ

### 2.3.9 PAD7 / AN07 / ETRIG0 — Port AD Input Pin of ATD0

PAD7 is a general purpose input pin and analog input AN7 of the analog to digital converter ATD0. It can act as an external trigger input for the ATD0.

### 2.3.10 PAD[06:00] / AN[06:00] — Port AD Input Pins of ATD0

PAD06 - PAD00 are general purpose input pins and analog inputs AN[6:0] of the analog to digital converter ATD0.

### 2.3.11 PA[7:0] / ADDR[15:8] / DATA[15:8] — Port A I/O Pins

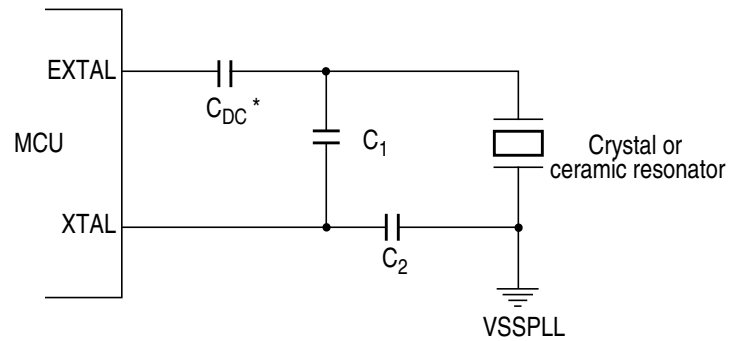
PA7-PA0 are general purpose input or output pins. In MCU expanded modes of operation, these pins are used for the multiplexed external address and data bus.

### 2.3.12 PB[7:0] / ADDR[7:0] / DATA[7:0] — Port B I/O Pins

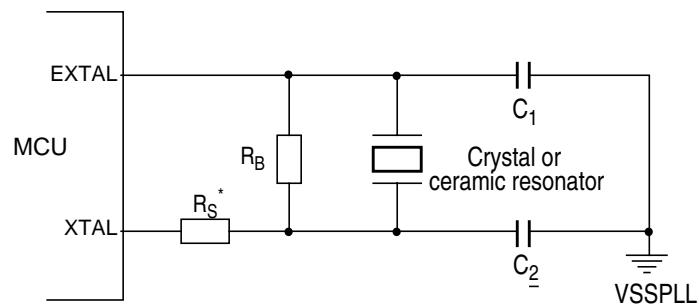
PB7-PB0 are general purpose input or output pins. In MCU expanded modes of operation, these pins are used for the multiplexed external address and data bus.

### 2.3.13 PE7 / NOACC / $\overline{\text{XCLKS}}$ — Port E I/O Pin 7

PE7 is a general purpose input or output pin. During MCU expanded modes of operation, the NOACC signal, when enabled, is used to indicate that the current bus cycle is an unused or “free” cycle. This signal will assert when the CPU is not using the bus. The  $\overline{\text{XCLKS}}$  is an input signal which controls whether a crystal in combination with the internal Colpitts (low power) oscillator is used or whether Pierce oscillator/external clock circuitry is used. The state of this pin is latched at the rising edge of  $\overline{\text{RESET}}$ . If the input is a logic low the EXTAL pin is configured for an external clock drive or a Pierce Oscillator. If input is a logic high a Colpitts oscillator circuit is configured on EXTAL and XTAL. Since this pin is an input with a pull-up device during reset, if the pin is left floating, the default configuration is a Colpitts oscillator circuit on EXTAL and XTAL.

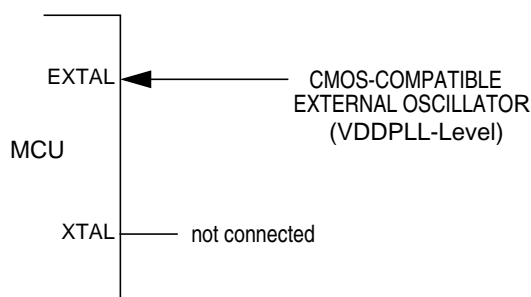
**Figure 2-4 Colpitts Oscillator Connections (PE7=1)**

- \* Due to the nature of a translated ground Colpitts oscillator a DC voltage bias is applied to the crystal  
 .Please contact the crystal manufacturer for crystal DC

**Figure 2-5 Pierce Oscillator Connections (PE7=0)**

- \*  $R_S$  can be zero (shorted) when use with higher frequency crystals.  
 Refer to manufacturer's data.

Figure 2-6 External Clock Connections (PE7=0)



### 2.3.14 PE6 / MODB / IPIPE1 — Port E I/O Pin 6

PE6 is a general purpose input or output pin. It is used as a MCU operating mode select pin during reset. The state of this pin is latched to the MODB bit at the rising edge of  $\overline{\text{RESET}}$ . This pin is shared with the instruction queue tracking signal IPIPE1. This pin is an input with a pull-down device which is only active when  $\overline{\text{RESET}}$  is low.

### 2.3.15 PE5 / MODA / IPIPE0 — Port E I/O Pin 5

PE5 is a general purpose input or output pin. It is used as a MCU operating mode select pin during reset. The state of this pin is latched to the MODA bit at the rising edge of  $\overline{\text{RESET}}$ . This pin is shared with the instruction queue tracking signal IPIPE0. This pin is an input with a pull-down device which is only active when  $\overline{\text{RESET}}$  is low.

### 2.3.16 PE4 / ECLK — Port E I/O Pin 4

PE4 is a general purpose input or output pin. It can be configured to drive the internal bus clock ECLK. ECLK can be used as a timing reference.

### 2.3.17 PE3 / $\overline{\text{LSTRB}}$ / $\overline{\text{TAGLO}}$ — Port E I/O Pin 3

PE3 is a general purpose input or output pin. In MCU expanded modes of operation,  $\overline{\text{LSTRB}}$  can be used for the low-byte strobe function to indicate the type of bus access and when instruction tagging is on,  $\overline{\text{TAGLO}}$  is used to tag the low half of the instruction word being read into the instruction queue.

### 2.3.47 PP2 / KWP2 / PWM2 / SCK1 — Port P I/O Pin 2

PP2 is a general purpose input or output pin. It can be configured to generate an interrupt causing the MCU to exit STOP or WAIT mode. It can be configured as Pulse Width Modulator (PWM) channel 2 output. It can be configured as serial clock pin SCK of the Serial Peripheral Interface 1 (SPI1).

### 2.3.48 PP1 / KWP1 / PWM1 / MOSI1 — Port P I/O Pin 1

PP1 is a general purpose input or output pin. It can be configured to generate an interrupt causing the MCU to exit STOP or WAIT mode. It can be configured as Pulse Width Modulator (PWM) channel 1 output. It can be configured as master output (during master mode) or slave input pin (during slave mode) MOSI of the Serial Peripheral Interface 1 (SPI1).

### 2.3.49 PP0 / KWP0 / PWM0 / MISO1 — Port P I/O Pin 0

PP0 is a general purpose input or output pin. It can be configured to generate an interrupt causing the MCU to exit STOP or WAIT mode. It can be configured as Pulse Width Modulator (PWM) channel 0 output. It can be configured as master input (during master mode) or slave output (during slave mode) pin MISO of the Serial Peripheral Interface 1 (SPI1).

### 2.3.50 PS7 / $\overline{SS0}$ — Port S I/O Pin 7

PS6 is a general purpose input or output pin. It can be configured as the slave select pin  $\overline{SS}$  of the Serial Peripheral Interface 0 (SPI0).

### 2.3.51 PS6 / SCK0 — Port S I/O Pin 6

PS6 is a general purpose input or output pin. It can be configured as the serial clock pin SCK of the Serial Peripheral Interface 0 (SPI0).

### 2.3.52 PS5 / MOSI0 — Port S I/O Pin 5

PS5 is a general purpose input or output pin. It can be configured as master output (during master mode) or slave input pin (during slave mode) MOSI of the Serial Peripheral Interface 0 (SPI0).

### 2.3.53 PS4 / MISO0 — Port S I/O Pin 4

PS4 is a general purpose input or output pin. It can be configured as master input (during master mode) or slave output pin (during slave mode) MOSI of the Serial Peripheral Interface 0 (SPI0).

### 2.3.54 PS3 / TXD1 — Port S I/O Pin 3

PS3 is a general purpose input or output pin. It can be configured as the transmit pin TXD of Serial Communication Interface 1 (SCI1).



### 2.4.3 VDD1, VDD2, VSS1, VSS2 — Core Power Pins

Power is supplied to the MCU through VDD and VSS. Because fast signal transitions place high, short-duration current demands on the power supply, use bypass capacitors with high-frequency characteristics and place them as close to the MCU as possible. This 2.5V supply is derived from the internal voltage regulator. There is no static load on those pins allowed. The internal voltage regulator is turned off, if VREGEN is tied to ground.

**NOTE:** *No load allowed except for bypass capacitors.*

### 2.4.4 VDDA, VSSA — Power Supply Pins for ATD and VREG

VDDA, VSSA are the power supply and ground input pins for the voltage regulator and the analog to digital converter. It also provides the reference for the internal voltage regulator. This allows the supply voltage to the ATD and the reference voltage to be bypassed independently.

### 2.4.5 VRH, VRL — ATD Reference Voltage Input Pins

VRH and VRL are the reference voltage input pins for the analog to digital converter.

### 2.4.6 VDDPLL, VSSPLL — Power Supply Pins for PLL

Provides operating voltage and ground for the Oscillator and the Phased-Locked Loop. This allows the supply voltage to the Oscillator and PLL to be bypassed independently. This 2.5V voltage is generated by the internal voltage regulator.

**NOTE:** *No load allowed except for bypass capacitors.*

**Table 2-2 MC9S12DP256 Power and Ground Connection Summary**

Mnemonic	Pin Number	Nominal Voltage	Description
	112-pin QFP		
V <sub>DD1,2</sub>	13, 65	2.5 V	Internal power and ground generated by internal regulator
V <sub>SS1,2</sub>	14, 66	0V	
V <sub>DDR</sub>	41	5.0 V	External power and ground, supply to pin drivers and internal voltage regulator.
V <sub>SSR</sub>	40	0 V	
V <sub>DDX</sub>	107	5.0 V	External power and ground, supply to pin drivers.
V <sub>SSX</sub>	106	0 V	
V <sub>DDA</sub>	83	5.0 V	Operating voltage and ground for the analog-to-digital converters and the reference for the internal voltage regulator, allows the supply voltage to the A/D to be bypassed independently.
V <sub>SSA</sub>	86	0 V	
V <sub>RL</sub>	85	0 V	Reference voltages for the analog-to-digital converter.
V <sub>RH</sub>	84	5.0 V	

## Section 6 HCS12 Core Block Description

### 6.1 CPU12 Block Description

Consult the CPU12 Reference Manual for information on the CPU.

When the CPU12 Reference Manual refers to *cycles* this is equivalent to *Bus Clock Periods*.

### 6.2 HCS12 Module Mapping Control (MMC) Block Description

Consult the MMC Block User Guide for information on the Module Mapping Control Block.

#### 6.2.1 Device specific information

- INITEE
  - Reset state: \$01
  - Bits EE11-EE15 are writeable once in Normal and Emulation Mode
- PPAGE
  - Reset state : \$00
  - Register is writeable anytime in all modes

### 6.3 HCS12 Multiplexed External Bus Interface (MEBI) Block Description

Consult the MEBI Block Guide for information on Multiplexed External Bus Interface.

#### 6.3.1 Device specific information

- PUCR
  - Reset State : \$90

### 6.4 HCS12 Interrupt (INT) Block description

Consult the INT Block guide for information on HCS12 Interrupt block.

### 6.5 HCS12 Background Debug (BDM) Block Description

Consult the BDM Block guide for information on HCS12 Background Debug block

Consult the EETS4K Block User Guide for information about the EEPROM module.

## **Section 17 RAM Block Description**

This module supports single-cycle misaligned word accesses.

## **Section 18 MSCAN Block Description**

There are three MSCAN modules (CAN4, CAN1 and CAN0) implemented on the MC9S12DT256. Consult the MSCAN Block User Guide for information about the Motorola Scalable CAN Module.

## **Section 19 Port Integration Module (PIM) Block Description**

Consult the PIM\_9DP256 Block User Guide for information about the Port Integration Module.

## **Section 20 Voltage Regulator (VREG) Block Description**

Consult the VREG Block User Guide for information about the dual output linear voltage regulator.



## A.1.4 Current Injection

Power supply must maintain regulation within operating  $V_{DD5}$  or  $V_{DD}$  range during instantaneous and operating maximum current conditions. If positive injection current ( $V_{in} > V_{DD5}$ ) is greater than  $I_{DD5}$ , the injection current may flow out of VDD5 and could result in external power supply going out of regulation. Ensure external VDD5 load will shunt current greater than maximum injection current. This will be the greatest risk when the MCU is not consuming power; e.g. if no system clock is present, or if clock rate is very low which would reduce overall power consumption.

## A.1.5 Absolute Maximum Ratings

Absolute maximum ratings are stress ratings only. A functional operation under or outside those maxima is not guaranteed. Stress beyond those limits may affect the reliability or cause permanent damage of the device.

This device contains circuitry protecting against damage due to high static voltage or electrical fields; however, it is advised that normal precautions be taken to avoid application of any voltages higher than maximum-rated voltages to this high-impedance circuit. Reliability of operation is enhanced if unused inputs are tied to an appropriate logic voltage level (e.g., either  $V_{SS5}$  or  $V_{DD5}$ ).

**Table A-1 Absolute Maximum Ratings<sup>1</sup>**

Num	Rating	Symbol	Min	Max	Unit
1	I/O, Regulator and Analog Supply Voltage	$V_{DD5}$	-0.3	6.0	V
2	Digital Logic Supply Voltage <sup>2</sup>	$V_{DD}$	-0.3	3.0	V
3	PLL Supply Voltage <sup>2</sup>	$V_{DDPLL}$	-0.3	3.0	V
4	Voltage difference VDDX to VDDR and VDDA	$\Delta V_{DDX}$	-0.3	0.3	V
5	Voltage difference VSSX to VSSR and VSSA	$\Delta V_{SSX}$	-0.3	0.3	V
6	Digital I/O Input Voltage	$V_{IN}$	-0.3	6.0	V
7	Analog Reference	$V_{RH}, V_{RL}$	-0.3	6.0	V
8	XFC, EXTAL, XTAL inputs	$V_{ILV}$	-0.3	3.0	V
9	TEST input	$V_{TEST}$	-0.3	10.0	V
10	Instantaneous Maximum Current Single pin limit for all digital I/O pins <sup>3</sup>	$I_D$	-25	+25	mA
11	Instantaneous Maximum Current Single pin limit for XFC, EXTAL, XTAL <sup>4</sup>	$I_{DL}$	-25	+25	mA
12	Instantaneous Maximum Current Single pin limit for TEST <sup>5</sup>	$I_{DT}$	-0.25	0	mA
13	Storage Temperature Range	$T_{stg}$	- 65	155	°C

NOTES:

1. Beyond absolute maximum ratings device might be damaged.

**Table A-5 Thermal Package Characteristics<sup>1</sup>**

Num	C	Rating	Symbol	Min	Typ	Max	Unit
1	T	Thermal Resistance LQFP112, single sided PCB <sup>2</sup>	$\theta_{JA}$	-	-	54	°C/W
2	T	Thermal Resistance LQFP112, double sided PCB with 2 internal planes <sup>3</sup>	$\theta_{JA}$	-	-	41	°C/W
3	T	Thermal Resistance LQFP 80, single sided PCB	$\theta_{JA}$	-	-	51	°C/W
4	T	Thermal Resistance LQFP 80, double sided PCB with 2 internal planes	$\theta_{JA}$	-	-	41	°C/W

## NOTES:

1. The values for thermal resistance are achieved by package simulations
2. PC Board according to EIA/JEDEC Standard 51-2
3. PC Board according to EIA/JEDEC Standard 51-7

**A.1.9 I/O Characteristics**

This section describes the characteristics of all 5V I/O pins. All parameters are not always applicable, e.g. not all pins feature pull up/down resistances.

specifies results in an error of less than 1/2 LSB (2.5mV) at the maximum leakage current. If device or operating conditions are less than worst case or leakage-induced error is acceptable, larger values of source resistance is allowed.

### A.2.2.2 Source Capacitance

When sampling an additional internal capacitor is switched to the input. This can cause a voltage drop due to charge sharing with the external and the pin capacitance. For a maximum sampling error of the input voltage  $\leq 1\text{LSB}$ , then the external filter capacitor,  $C_f \geq 1024 * (C_{\text{INS}} - C_{\text{INN}})$ .

### A.2.2.3 Current Injection

There are two cases to consider.

1. A current is injected into the channel being converted. The channel being stressed has conversion values of \$3FF (\$FF in 8-bit mode) for analog inputs greater than  $V_{\text{RH}}$  and \$000 for values less than  $V_{\text{RL}}$  unless the current is higher than specified as disruptive condition.
2. Current is injected into pins in the neighborhood of the channel being converted. A portion of this current is picked up by the channel (coupling ratio K), This additional current impacts the accuracy of the conversion depending on the source resistance.

The additional input voltage error on the converted channel can be calculated as  $V_{\text{ERR}} = K * R_S * I_{\text{INJ}}$ , with  $I_{\text{INJ}}$  being the sum of the currents injected into the two pins adjacent to the converted channel.

**Table A-9 ATD Electrical Characteristics**

Conditions are shown in <b>Table A-4</b> unless otherwise noted							
Num	C	Rating	Symbol	Min	Typ	Max	Unit
1	C	Max input Source Resistance	$R_S$	-	-	1	$K\Omega$
2	T	Total Input Capacitance Non Sampling Sampling	$C_{\text{INN}}$ $C_{\text{INS}}$			10 22	pF
3	C	Disruptive Analog Input Current	$I_{\text{NA}}$	-2.5		2.5	mA
4	C	Coupling Ratio positive current injection	$K_p$			$10^{-4}$	A/A
5	C	Coupling Ratio negative current injection	$K_n$			$10^{-2}$	A/A

3. Maximum Erase and Programming times are achieved under particular combinations of  $f_{\text{NVMOP}}$  and bus frequency  $f_{\text{bus}}$ . Refer to formulae in Sections **A.3.1.1 - A.3.1.4** for guidance.
4. Burst Programming operations are not applicable to EEPROM
5. Minimum Erase times are achieved under maximum NVM operating frequency  $f_{\text{NVMOP}}$ .
6. Minimum time, if first word in the array is not blank
7. Maximum time to complete check on an erased block

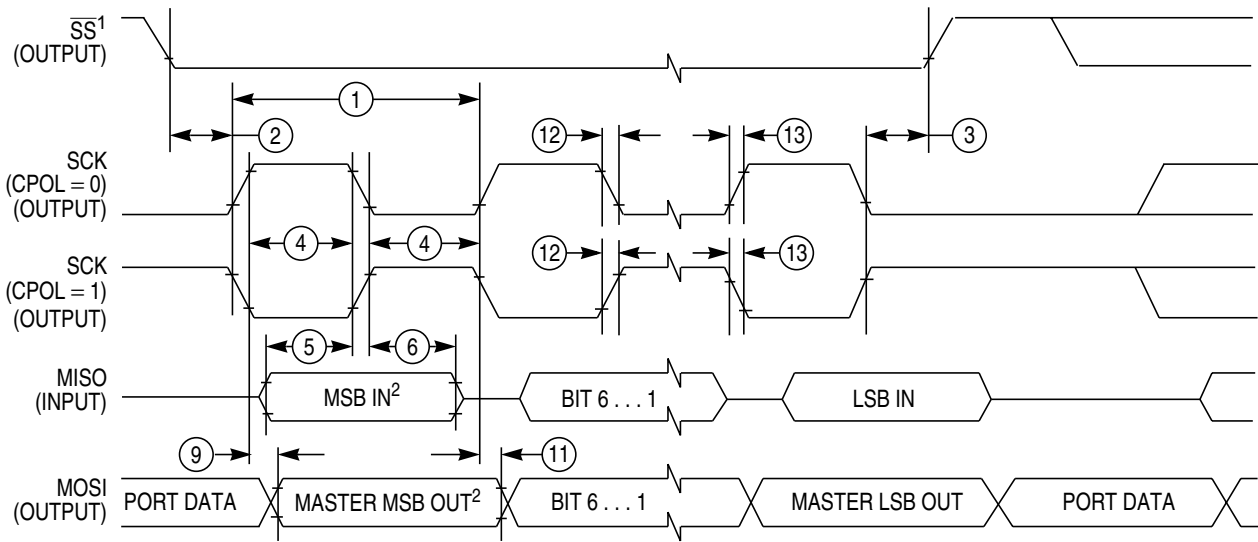


## A.4 Voltage Regulator

The on-chip voltage regulator is intended to supply the internal logic and oscillator circuits. No external DC load is allowed.

**Table A-13 Voltage Regulator Recommended Load Capacitances**

Rating	Symbol	Min	Typ	Max	Unit
Load Capacitance on VDD1, 2	$C_{LVDD}$		220		nF
Load Capacitance on VDDPLL	$C_{LVDDfcPLL}$		220		nF



- 1. If configured as output
- 2. LSBF = 0. For LSBF = 1, bit order is LSB, bit 1, ..., bit 6, MSB.

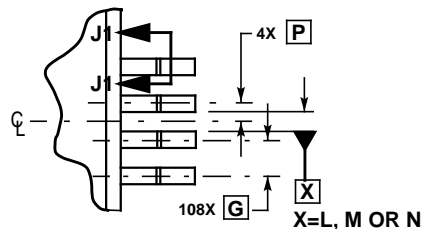
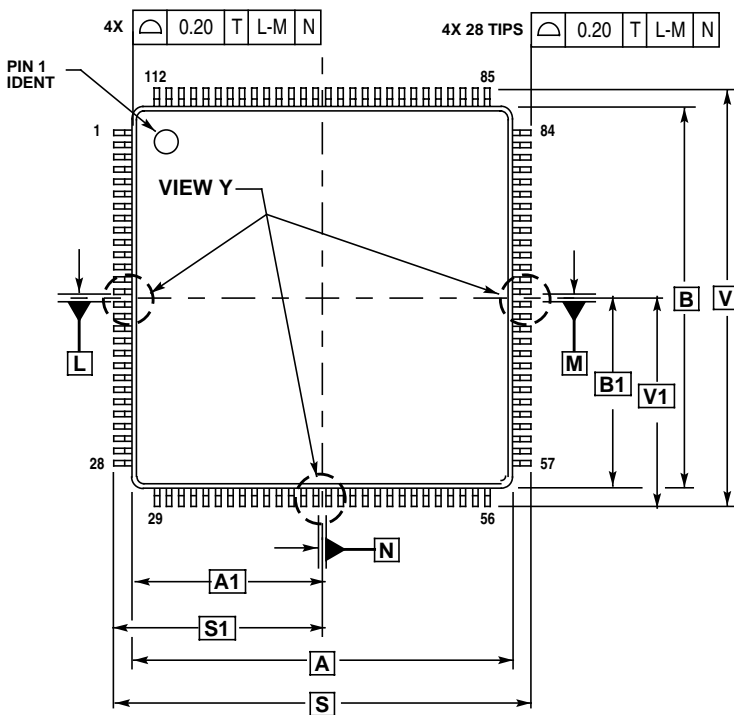
**Figure A-7 SPI Master Timing (CPHA=1)**

In **Table A-19** the timing characteristics for master mode are listed.

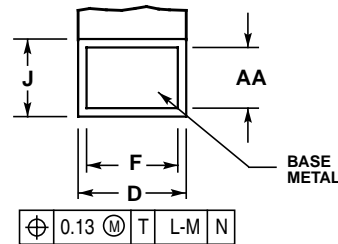
**Table A-19 SPI Master Mode Timing Characteristics**

Num	Characteristic	Symbol	Min	Typ	Max	Unit
1	SCK Frequency	$f_{sck}$	1/2048	—	1/2	$f_{bus}$
1	SCK Period	$t_{sck}$	2	—	2048	$t_{bus}$
2	Enable Lead Time	$t_{lead}$	—	1/2	—	$t_{sck}$
3	Enable Lag Time	$t_{lag}$	—	1/2	—	$t_{sck}$
4	Clock (SCK) High or Low Time	$t_{wsck}$	—	1/2	—	$t_{sck}$
5	Data Setup Time (Inputs)	$t_{su}$	8	—	—	ns
6	Data Hold Time (Inputs)	$t_{hi}$	8	—	—	ns
9	Data Valid after SCK Edge	$t_{vsck}$	—	—	30	ns
10	Data Valid after $\overline{SS}$ fall (CPHA=0)	$t_{vss}$	—	—	15	ns
11	Data Hold Time (Outputs)	$t_{ho}$	20	—	—	ns
12	Rise and Fall Time Inputs	$t_{rfi}$	—	—	8	ns
13	Rise and Fall Time Outputs	$t_{rfo}$	—	—	8	ns

## B.2 112-pin LQFP package



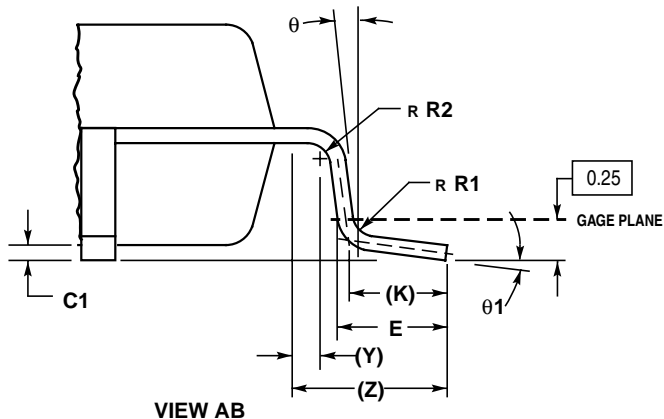
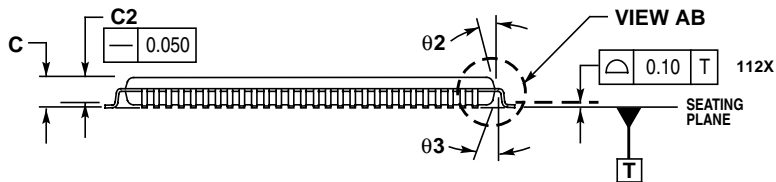
VIEW Y



SECTION J1-J1  
ROTATED 90° COUNTERCLOCKWISE

NOTES:

1. DIMENSIONING AND TOLERANCING PER ASME Y14.5M, 1994.
2. DIMENSIONS IN MILLIMETERS.
3. DATUMS L, M AND N TO BE DETERMINED AT SEATING PLANE, DATUM T.
4. DIMENSIONS S AND V TO BE DETERMINED AT SEATING PLANE, DATUM T.
5. DIMENSIONS A AND B DO NOT INCLUDE MOLD PROTRUSION. ALLOWABLE PROTRUSION IS 0.25 PER SIDE. DIMENSIONS A AND B INCLUDE MOLD MISMATCH.
6. DIMENSION D DOES NOT INCLUDE DAMBAR PROTRUSION. ALLOWABLE DAMBAR PROTRUSION SHALL NOT CAUSE THE D DIMENSION TO EXCEED 0.46.



DIM	MILLIMETERS	
	MIN	MAX
A	20.000	BSC
A1	10.000	BSC
B	20.000	BSC
B1	10.000	BSC
C	---	1.600
C1	0.050	0.150
C2	1.350	1.450
D	0.270	0.370
E	0.450	0.750
F	0.270	0.330
G	0.650	BSC
J	0.090	0.170
K	0.500	REF
P	0.325	BSC
R1	0.100	0.200
R2	0.100	0.200
S	22.000	BSC
S1	11.000	BSC
V	22.000	BSC
V1	11.000	BSC
Y	0.250	REF
Z	1.000	REF
AA	0.090	0.160
θ	0°	8°
θ1	3°	7°
θ2	11°	13°
θ3	11°	13°

Figure B-1 112-pin LQFP mechanical dimensions (case no. 987)



# User Guide End Sheet